Ultrasensitive Photodetectors Based on Island-Structured CH₃NH₃PbI₃ Thin Films

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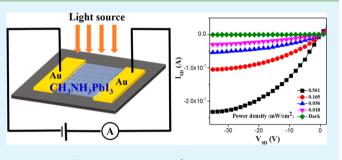
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Supporting Information

ABSTRACT: CH₃NH₃PbI₃ perovskite-based optoelectronics have attracted intense research interests recently because of their easy fabrication process and high power conversion efficiency. Herein, we report a novel photodetector based on unique CH₃NH₃PbI₃ perovskite films with island-structured morphology. The light-induced electronic properties of the photodetectors were investigated and compared to those devices based on conventional compact CH₃NH₃PbI₃ films. The island-structured CH₃NH₃PbI₃ photodetectors exhibited a rapid response speed (<50 ms), good stability at a



temperature of up to 100 °C, a large photocurrent to dark current ratio $(I_{\text{light}}/I_{\text{dark}} > 1 \times 10^4 \text{ under an incident light of } \sim 6.59 \text{ mW/cm}^2$, and $I_{\text{light}}/I_{\text{dark}} > 1 \times 10^2$ under low incident light $\sim 0.018 \text{ mW/cm}^2$), and excellent reproducibility. Especially, the performance of the island-structured devices markedly exceed that of the conventional compact CH₃NH₃PbI₃ thin-film devices. These excellent performances render the island-structured device to be potentially applicable for a wide range of optoelectronics.

KEYWORDS: photodetector, CH₃NH₃PbI₃ perovskites, high sensitivity, island-structured thin film, sensor

hotodetectors can convert optical signals to electrical signals. They are essential elements applied in communications, environmental monitoring, optoelectronic circuits, and intelligent buildings.¹⁻³ In the past decade, extensive efforts have been devoted to explore the next generation photodetector materials, such as In₂Te₃, ZnO, and GaN, with low noise, high photosensitivity, and good stability. However, many of the reported photodetector materials still suffer from limited photocurrent and photoresponse speed.⁴⁻⁶ Additionally, for a lot of practical applications, wide spectrum photodetection is necessary in order to improve the transmission rate and capacity. However, most of the studies on photodetectors or phototransistors mainly focused on light illumination under specific wavelength, because of the lack of proper materials that possess the ability to absorb incident radiation over a broad range of wavelength.^{7–9} On the other hand, nanostructured and microstructured materials, such as nanowires and nanoparticles, have been demonstrated to show high photosensitivity, because their large surface-to-volume ratio can enhance the light scattering effect and light harvesting, and thus exhibit photodetection performance better than bulky counterparts. However, these nanostructured and microstructured devices usually need precise synthetic fabrication process using a combination of lithography, etching, and deposition, which is complicated, time-consuming, and uneconomic. Therefore, it is

of great interest to develop new materials for high performance photodetectors by easy fabrication method.

Very recently, organolead halide perovskites, a new class of organic-inorganic hybrid materials, have attracted growing interests due to their easy fabrication and outstanding performances in photovoltaic devices and other optoelectronic devices.^{10–13} As an ideal active material for optoelectronic devices, the band gap of organolead halide perovskite matches the energy of visible and near-IR light spectrum region. Additionally, organolead halide perovskites feature weakly bounded excitons with long lifetimes (~300 ns), which is also a significant advantage for applications in photodetector devices.^{14,15} The production strategies of the hybrid perovskite thin film can be easily scaled and controlled. For example, Xie et al. and others had explored the photodetector applications based the CH₃NH₃PbI₃ thin film.^{11,16-18} The high sensitivity and fast response of those devices demonstrate the promising advantages in applications. However, the photocurrent (on the order of nA) and the $I_{\text{light}}/I_{\text{dark}}$ ratio (~300) of those devices could be further enhanced to extend the range of practical applications. Here in this work, we have significantly improved

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photodetector performance by controlling CH₃NH₃PbI₃ film morphology through a simple and cost-effective solution method. The obtained CH₃NH₃PbI₃ films were composed of continuous micrometer-sized islands networks instead of a compact surface, exhibiting wide optical absorption over a broad range of wavelength. Due to the existence of islands network, the performance of device was significantly enhanced comparing to that of the conventional compact CH₃NH₃PbI₃ devices. The photocurrent can be generated and annihilated within 50 ms. Devices showed significantly higher photocurrent to dark current ratio ($I_{light}/I_{dark} > 1 \times 10^4$ at ~6.59 mW/cm²) than that of previously reported devices.^{11,16,20} A decent I_{light}/I_{dark} ratio (>1 × 10²) can still be achieved even when the device was only exposed to a light as weak as 0.018 mW/cm². Moreover, device stability was demonstrated at high temperature up to 100 °C.

The surface topography and cross section image of the island-structured $CH_3NH_3PbI_3$ film on a substrate is shown in Figure 1a, b. The surface of organolead halide perovskite films

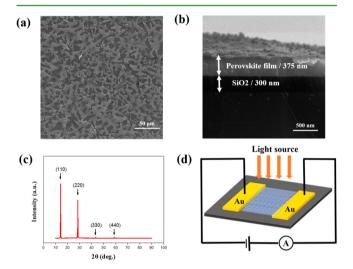


Figure 1. Scanning electron microscope (SEM) image of (a) $CH_3NH_3PbI_3$ perovskite thin film surface with island-structured morphology and (b) cross-sectional structure of the representative device. (c) XRD spectrum of the $CH_3NH_3PbI_3$ perovskite thin film on a glass substrate. (d) Schematic diagram of fabricated photodetector device components.

showed micrometer-sized islands forming random networks. The cross section image shows that the thickness of CH₃NH₃PbI₃ layer is about 375 nm. The result of Energy Dispersive Analysis System of X-ray (EDX) confirms the element ratio of CH₃NH₃PbI₃ (shown in Figure S1). No other foreign substances were presented. Figure 1c depicts the X-ray diffraction (XRD) spectrum of the prepared perovskite film spin-coated on a glass substrate. Four characteristic peaks centered at 14.16°, 28.50, 43.28, and 58.90° are assigned to the 110, 220, 330, and 440 planes of a tetragonal perovskite crystal structure with lattice parameter of a = 8.825 Å, b = 8.835 Å, c =11.24 Å, which is consistent with literatures reported.^{13,19} As shown in Figure S2, the strong and wide absorbance of the island-structured film demonstrates good light-harvesting capability over wavelength from 300 to 1000 nm range. Detailed device fabrication and measurement methods are introduced in the Supporting Information. Figure 1d shows a schematic diagram of the photodetector device structure. The CH₃NH₃PbI₃ film serves as the photosensitive material, and

gold contacts act as electrodes to provide the bias voltage. A power-tunable white-light LED with wavelength ranging from 400 to 800 nm was used as the illumination source. The incident light power density was recorded using a commercial power meter (PM100D, Thorlabs). Electrical characterizations were recorded under different illumination power intensities. The measurements were carried out by sweeping the bias voltage between the two electrodes and tuning the illumination from dark to a given power density.

Figure 2a, b shows the photocurrent of the device as a function of bias voltages between two gold electrodes under

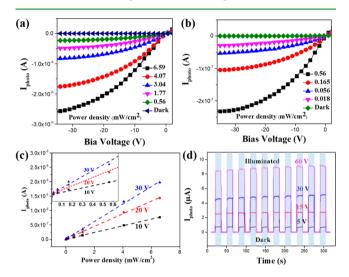


Figure 2. (a, b) I-V characteristics of CH₃NH₃PbI₃ photodetectosr under different illumination power density. (c) Depencency of photocurrent on incident light power density and bias voltage; inset shows the magnification of the low power density region. (d) Transient photoresponse properties with bias voltage of 5, 15, 30, and 60 V under a power density of 6.59 mW/cm².

different incident light power densities. The photodetector current-voltage (I-V) characteristics were depicted both at low (0.018-0.561 mW/cm²) and at high (0.56-6.59 mW/ cm²) light power densities range. The dark current of this photodetector at 30 V is ultralow ($\sim 1 \times 10^{-10}$ A) in this case, After illuminating with a light power density of 6.59 mW/cm^2 , the photocurrent increased by more than 10000 times compared to that of the dark circumstance. Photodetectors usually have two modes: photoconductive mode and photovoltaic mode.³ In our case, the device acts as an insulator under dark circumstance, and the photocurrent arises dramatically with the increase of light illumination, which exhibits as a typical photoconductive mode. Here, the photocurrent can be attributed to the electron-hole pairs generated by the incident phonons with energy equal or larger than the band gap. Compared with photodetectors based on conventional CH₃NH₃PbI₃ compact film, the island-structured thin films have a larger surface-to-volume ratio and thus contain more radiating area under similar illumination condition. As a result, the present photocurrent is significantly higher than that of devices with conventional CH₃NH₃PbI₃ compact film.^{16,20}

The ultralow dark current suggests that the island-structured $CH_3NH_3PbI_3$ films are highly resistive in dark. Usually a low dark current is also essential to a high performance photodetectors device. The ultralow dark current of this photodetector may partially arise from the island-structured topography, because the physical boundaries among the CH₃NH₃PbI₃ islands can hinder charge transport. Because of the ultralow dark current, another remarkable feature of this device is the good photosensitivity to weak light illumination. As shown in Figure 2b, a decent $I_{\text{light}}/I_{\text{dark}}$ ratio (>1 × 10²) can still be achieved even when the device was only exposed to a light as weak as 0.018 mW/cm². When a higher illumination intensity (~6.59 mW/cm²) was used, devices showed significantly higher photocurrent to dark current ratio ($I_{\text{light}}/I_{\text{dark}} > 1 \times 10^4$) than that of most previously reported CH₃NH₃PbI₃ photodetectors to the best of our knowledge.

The displayed high sensitivity to weak light illumination and large $I_{\text{light}}/I_{\text{dark}}$ ratio of the presented photodetector is also better than a lot of nanomaterials-based device.^{5,21,22} Such a drastic enhancement in these properties is very promising for practical applications such as photodiodes, current modification and signal magnification.^{23–25}

The I-V curves under light illumination show nonlinear dependence on the applied bias voltage, similar to field-effect transistors. From the I-V curve in darkness (Figure S6a), we also observed the nonlinear and asymmetry characteristics at room temperature, confirming the existence of non-Ohmic contact. However, the I-V curve in darkness is more linear at higher temperature, as shown in Figure S6b. It is possible that water and oxygen molecules were trapped in the active material at room temperature, which induce charge trapping effect and slightly shifted energy level of the active material. The mismatch between the energy level of CH₃NH₃PbI₃ active material and the Fermi level of gold electrode lead to the non-Ohmic contact. When the temperature increased, trapped molecules can be detrapped from the film and then the I-Vcurve is more linear. In addition, the energy level of CH₃NH₃PbI₃ and the charge density is also the function of temperature. Increasing the temperature might reduce the energy level mismatch and thus lead to more linear I-V curves. Because the dark current is very low ($\sim 1 \times 10^{-10}$ A), signal noise can also contribute to the nonlinearity of the I-V curves in darkness.

As plotted in Figure 2c, the photocurrent is linearly proportional to the incident irradiation intensity, with the fitted curve displaying different gradients corresponding to different applied voltages. Within the linear range, the islands-structured $CH_3NH_3PbI_3$ film acts as a typical photon-dependent detector. The current increases with the increasing of light power because the excited charge density increases with the increased photon number density. The linear dependence can be maintained in weak illumination range, as shown in the inset of Figure 2c. Moreover, this linear dependence can be maintained for different bias voltages. Similar to transistors using both gate voltages and a source—drain voltages to control the source—drain currents, in this case, the photodetectors can actually use both the incident light power densities and the applied bias voltages to modulate the photocurrents.

To further characterize the stability of the photocurrent response, we studied the transient photoresponse behavior of the devices with the illumination switched on and off at different bias voltages (5, 15, 30, and 60 V), as shown in Figure 2d. The duration of the on and off states was both sustained for 15 s. There is nearly no significant variation in the signal amplitude during the on/off cycles, indicating a good reversibility and stability of the device.

In addition to the intrinsic properties of $CH_3NH_3PbI_3$ perovskite materials, here the high I_{light}/I_{dark} ratio should also be attributed to the island networks morphology of $CH_3NH_3PbI_3$ film. The amounts of $CH_3NH_3PbCl_3$ used during fabrication was found to be critical for the resulting film morphology (see details in Materials and Methods in the Supporting Information). By using 1.5 and 0.75 mmol $CH_3NH_3PbCl_3$ in the precursor solutions, compact and island-structured $CH_3NH_3PbI_3$ films were obtained, respectively. As shown in Figure 3, the compact film has no islands

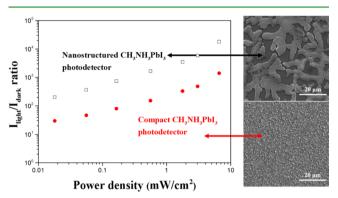


Figure 3. Comparison of $I_{\rm light}/I_{\rm dark}$ ratio under various illumination power densities at a vias of 30 V between island-structured and compact CH₃NH₃PbI₃ photodetector, and their corresponding SEM images showing film morphology.

features because the increased amount of CH₃NH₃PbCl₃ could improve the crystallization of CH₃NH₃PbI₃ and lead to uniform films. It was reported that the compact CH₃NH₃PbI₃ significantly improved the power conversion efficiency of planar CH₂NH₃PbI₃ solar cells.¹⁹ However, in the application of photodetector, as shown in Figure 3, the $I_{\text{light}}/I_{\text{dark}}$ ratios of the device based on island structured CH₃NH₃PbI₃ are 1 order of magnitude higher than that of compact devices. The enhanced performance of island-structured CH₃NH₃PbI₃ might result both from the large surface-to-volume ratio and from the continuous island-structured networks. Large surface-to-volume ratio can enhance the light scattering effect and light harvesting of the active material. In addition, we believe that the charge transport in the island-structured perovskite films can be affected both by the semiconductor/metal interface, and by the interactions between neighboring islands due to the presence of boundaries. During charge transportation, the excited charges have to travel through these junction barriers among the micrometer-sized CH₃NH₃PbI₃ islands. Upon illumination, the increased charge density in each CH₃NH₃PbI₃ islands would lower the effective energy barrier height, which then allow easier charge tunneling and transportation than that of devices in darkness. This process results in a significant increase in the conductivity of the islands network. This mechanism, named "hopping-like" transportation, has also been successfully used to interpret the performance of other network-structured thin film device.²⁶⁻²⁸ This interesting result helps to better understand the behavior of CH₃NH₃PbI₃ perovskite and other photosensitive materials.

Photoresponse speed is another key factor for photodetector. It determines the capability of a photodetector to follow a fast-varying optical signal. Here, promising device performance was also demonstrated by the fast response of our island-structured CH₃NH₃PbI₃ photodetector to light with a stepwise varying power density, as shown in Figure 4a. The time responses have been investigated at a bias 30 V, with light power densities of

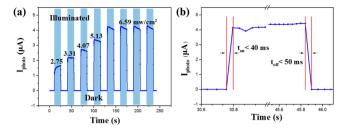


Figure 4. (a) Transient photoresponse characteristics of perovskite photodetector at different illumination power density. (b) Single photocurrent response cycle with light irradiation on and off, showing the response speed of the photodetector.

2.75, 3.31, 4.07, 5.13, and 6.59 mW/cm² being used. The light source was turned on and off for 15s each. Figure 4b shows that the device response time can be estimated from the enlarged portion of the plot containing one illumination on-off sequence. The response time, t_{on} and t_{off} is defined as the photocurrent to increase from 10% to 90% of the peak value or vice versa, respectively. Both the response and recovery processes were completed rapidly, and the response time were less than 50 ms in both cases. It should be pointed out that the 50 ms response time was limited by our photocurrent measurement instrument. These observations indicate that the island-structured perovskite photodetectors have a rapid response time comparable to or faster than ZnO- and GaN-based semiconductor photodetectors.^{1,2,29}

Such a fast response speed can also be attributed to the "hopping-like" charge transfer process. As previously discussed, the light illumination can increase excited charge density and then lower the energy barriers height between islands. When the light is turned off, the barrier height returns to its initial value in dark. The light-induced modulation of the barrier height between two adjacent $CH_3NH_3PbI_3$ islands should be a fast process upon varying the light, contributing to the fast response time of the device.^{26,27}

In practical applications, the induced in situ heating, trapped electrons or contamination can cause device instability. In this concern, two series measurements were performed to study the stability of our device. First, we recorded the photocurrent for 150 s at various light power densities (6.59, 5.13, 4.07 mW/ cm²) with a bias voltage of 30 V. The result shows that the current maintains nearly stable without obvious decay, indicating excellent device stability (as shown in Figure S4). In addition, we measured the *I*–*V* characteristics at various temperatures. As shown in Figure S5b, c, the CH₃NH₃PbI₃ based phototransistor works well at both 60 and 100 °C. The $I_{\text{light}/I_{\text{dark}}}$ ratio could still achieve around 1×10^4 level at high temperature (100 °C).

In conclusion, island-structured $CH_3NH_3PbI_3$ perovskite films were developed by a simple solution-phase method and incorporated into photodetectors. The constructed devices showed high photosensitivity, excellent stability, high I_{light}/I_{dark} ratio, and rapid response speed. It is found that these excellent photodetector performances should be particularly attributed to the unique micrometer-sized islands networks morphology of organic–inorganic hybrid $CH_3NH_3PbI_3$. Compared to devices fabricated using compact $CH_3NH_3PbI_3$ films, the islandstructured $CH_3NH_3PbI_3$ photodetector exhibited 1 order of magnitude higher photocurrent and I_{light}/I_{dark} ratio due to the presence of neighboring islands and the "hopping-like" charge transfer. The excellent performances and mechanism understanding open up possibilities of using island-structured hybrid perovskite for the next-generation photodetectors.

ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsami.5b05221.

Materials and Methods, energy-dispersive analysis system of X-ray and UV-visible absorbance spectrum results, device $I_{\text{light}}/I_{\text{dark}}$ ratio under different working voltage, device stability of long-term measurement, device temperature stability, I-V curves in the darkness of the island-structured photodetector at various temperatures (PDF)

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Notes

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